Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,881	YANG ET AL.	
Examiner	Art Unit	
Edward Wojciechowicz	2815	

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST 257/156,163,297 LEAKAGE +CARBON"	7-15-08	Eh
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